ABSTRACT OF THE DISCLOSURE

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A semiconductor integrated circuit device including (a) an actual input

circuit (03A, 04A), (b) an actual output circuit (05A, 06A), (c) a replica input

circuit (12A) having the same characteristics as those of the actual input circuit,

(d) a replica output circuit (11A) having the same characteristics as those of the

actual input circuit, (e) an oscillating circuit (15A) which operates in accordance

with external triggers, and (f) a skew-comparing circuit (10A) which compares a

signal transmitted from the oscillating circuit and passing through the actual

input circuit and the actual output circuit, to a signal transmitted from the

oscillating circuit and passing through the replica input circuit and the replica

output circuit to detect a delay error between the actual input and output circuits

and the replica input and output circuits, wherein delays in the replica input and

output circuits are compensated for in accordance with the delay error detected

by the skew-comparing circuit.

Drawing to be published: FIG. 3

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